National Institute of Advanced Manufacturing Technology Central Instrument Facility

Requisition form for X-Ray Diffraction: Residual Stress Analysis (For External users)

							Date:	
Name of the user:					Name of the supervisor:			
Designation of user:					Department:			
	•	ress of the	institute	/				
Indu								
Contact No.					No. of Samples submitted:			
Email ID:					Nature of samples: Hazardous / Non-hazardou			
Test/s	s to be do	ne: Please	provide	the follow	ing deta	ils:		
S	Sample	Material	Stress	Scan	hkl	Young's	Poisson's	Sample
No.	Name	Name	free angle	Range 2θ=_to_	valu	e modulus (MPa)	ratio (v)	Recollection (Yes/No)
							1	
							†	
Rema	rks, if any	: :						
Signa	ture of use	er	Sign	nature of supervisor Signature of Head/In-charge				
				<u>For</u>	CIF Us	<u>e</u>		
Date (of Comple	etion:				S:	ignature of T	Γechnician
				Details	of Payn	<u>nent</u>		
Nam	e of the u	ser/payer:						
No.	of sample	s/test to be	done:					
No.	of 30 min.	. slot requii	red:					
Total amount paid:				Rs.				
Date of Transaction:								
Mode of Payment:				UPI app (G-Pay / Phonepe / Paytm / Whatsapp / others) / NEFT / IMPS				
Tran	saction II)·						

Yes / No

Signature of user

Copy of transaction attached: